

TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (π -MOS VI)

TK16H60C

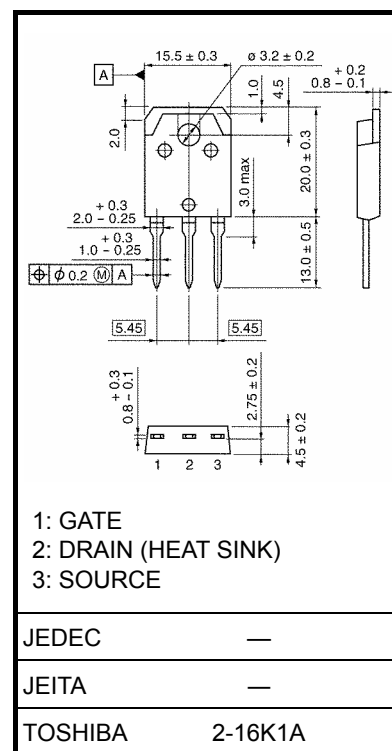
Switching Regulator Applications

Unit: mm

- Low drain-source ON resistance : $R_{DS(ON)} = 0.32\Omega$ (typ.)
- High forward transfer admittance : $|Y_{fs}| = 11S$ (typ.)
- Low leakage current : $I_{DSS} = 100\mu A$ (max) ($V_{DS} = 600V$)
- Enhancement mode : $V_{th} = 2.0\sim 4.0V$ ($V_{DS} = 10V$, $I_D = 1mA$)

Absolute Maximum Ratings ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Drain-source voltage	V_{DSS}	600	V
Drain-gate voltage ($R_{GS} = 20k\Omega$)	V_{DGR}	600	V
Gate-source voltage	V_{GSS}	± 30	V
Drain current	DC (Note 1)	I_D	16
	Pulse (Note 1)	I_{DP}	64
Drain power dissipation ($T_c = 25^\circ C$)	P_D	150	W
Single-pulse avalanche energy (Note 2)	E_{AS}	979	mJ
Avalanche current	I_{AR}	16	A
Repetitive avalanche energy (Note 3)	E_{AR}	15	mJ
Channel temperature	T_{ch}	150	$^\circ C$
Storage temperature range	T_{stg}	$-55\sim 150$	$^\circ C$



Weight: 3.8 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

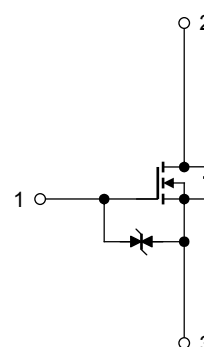
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case	$R_{th(ch-c)}$	0.833	$^\circ C / W$
Thermal resistance, channel to ambient	$R_{th(ch-a)}$	50	$^\circ C / W$

Note 1: Ensure that the channel temperature does not exceed $150^\circ C$.

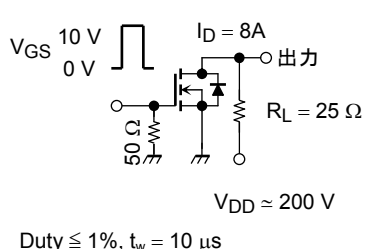
Note 2: $V_{DD} = 90V$, $T_{ch} = 25^\circ C$ (initial), $L = 6.69mH$, $R_G = 25\Omega$, $I_{AR} = 16A$

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



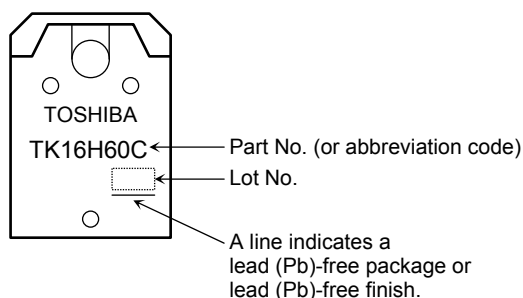
Electrical Characteristics (Ta = 25°C)

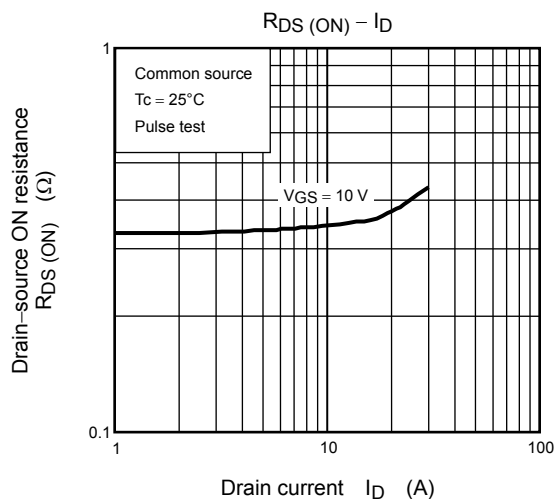
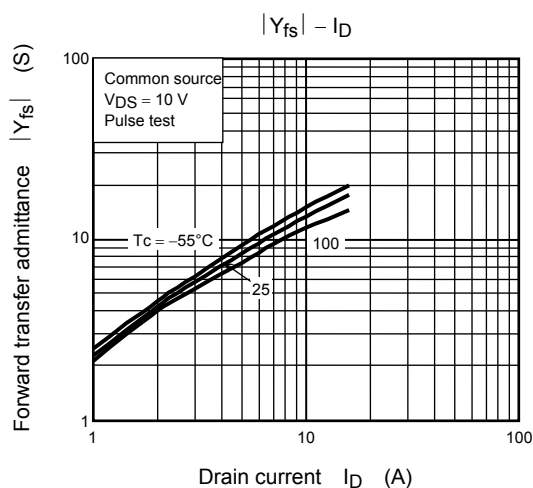
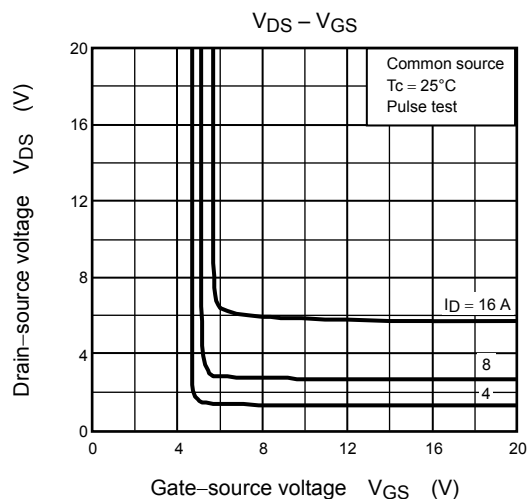
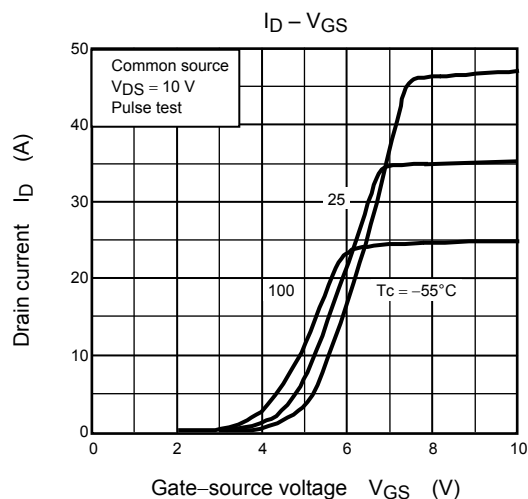
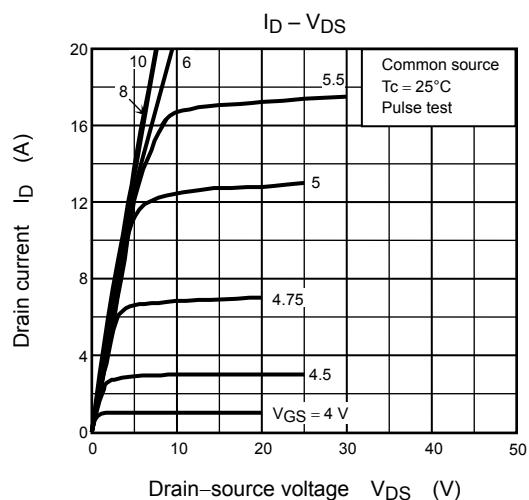
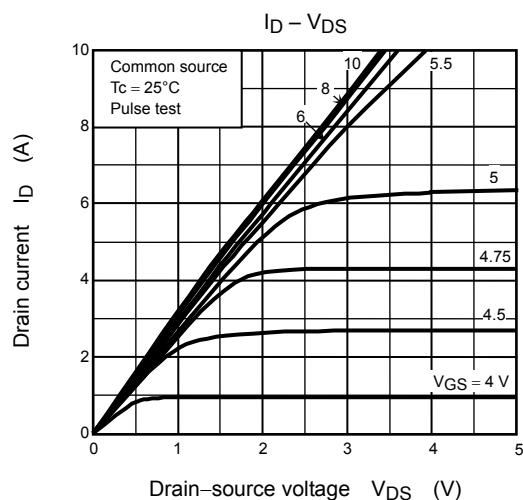
Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	—	—	± 10	μA
Gate-source breakdown voltage		$V_{(BR) GSS}$	$I_G = \pm 10 \mu\text{A}, V_{DS} = 0 \text{ V}$	± 30	—	—	V
Drain cutoff current		I_{DSS}	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$	—	—	100	μA
Drain-source breakdown voltage		$V_{(BR) DSS}$	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	600	—	—	V
Gate threshold voltage		V_{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	2.0	—	4.0	V
Drain-source ON resistance		$R_{DS(ON)}$	$V_{GS} = 10 \text{ V}, I_D = 8 \text{ A}$	—	0.32	0.4	Ω
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = 10 \text{ V}, I_D = 8 \text{ A}$	3.0	11	—	S
Input capacitance		C_{iss}	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	—	3100	—	pF
Reverse transfer capacitance		C_{rss}		—	20	—	
Output capacitance		C_{oss}		—	270	—	
Switching time	Rise time	t_r	 <p>$V_{GS} = 10 \text{ V}, 0 \text{ V}$ $I_D = 8 \text{ A}$ $R_L = 25 \Omega$ $V_{DD} \approx 200 \text{ V}$ $\text{Duty} \leq 1\%, t_w = 10 \mu\text{s}$</p>	—	60	—	ns
	Turn-on time	t_{on}		—	110	—	
	Fall time	t_f		—	50	—	
	Turn-off time	t_{off}		—	215	—	
Total gate charge (gate-source plus gate-drain)		Q_g	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 16 \text{ A}$	—	62	—	nC
Gate-source charge		Q_{gs}		—	40	—	
Gate-drain ("Miller") charge		Q_{gd}		—	22	—	

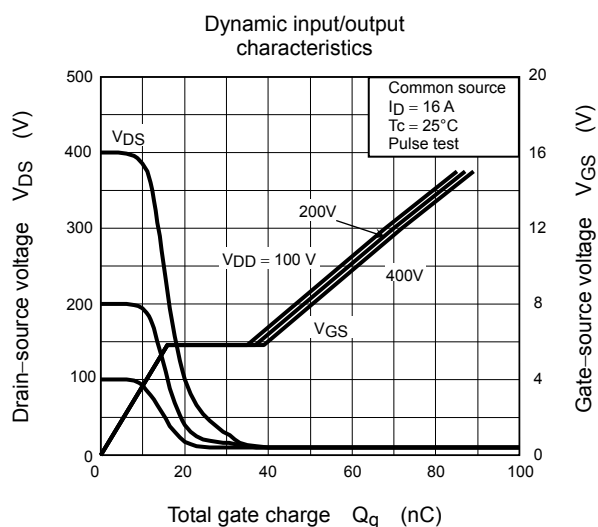
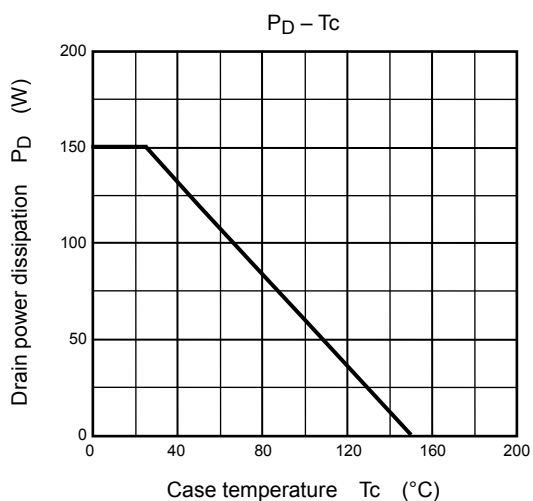
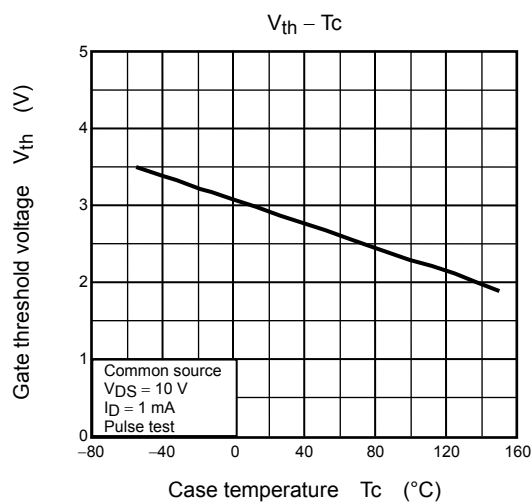
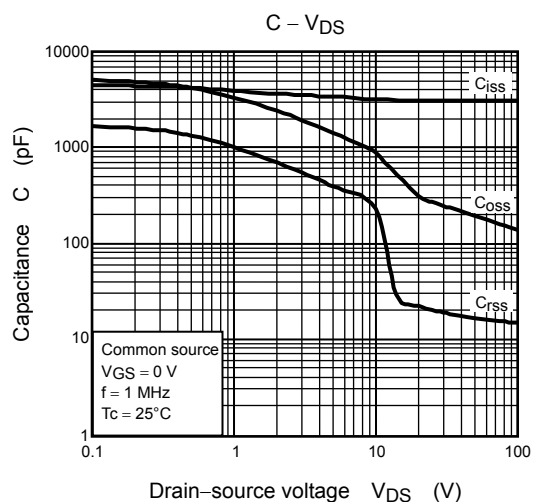
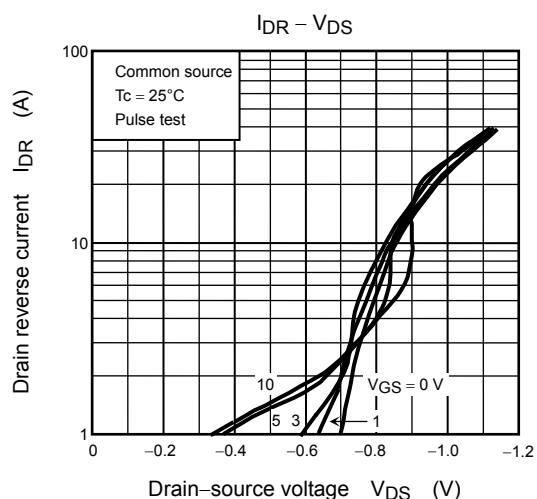
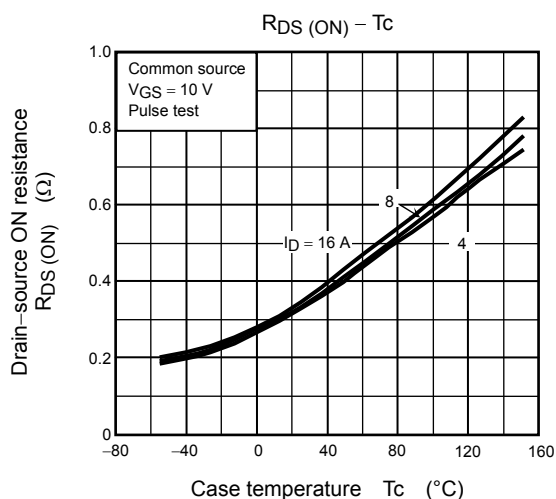
Source-Drain Ratings and Characteristics (Ta = 25°C)

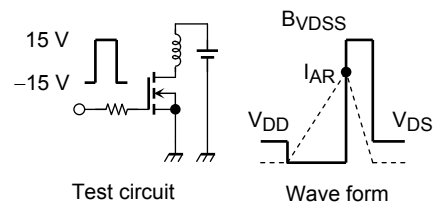
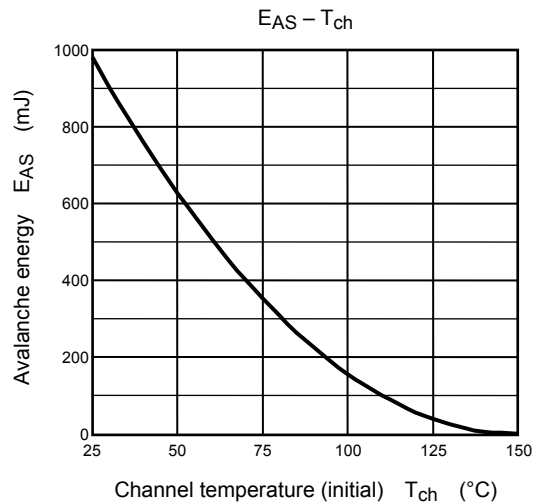
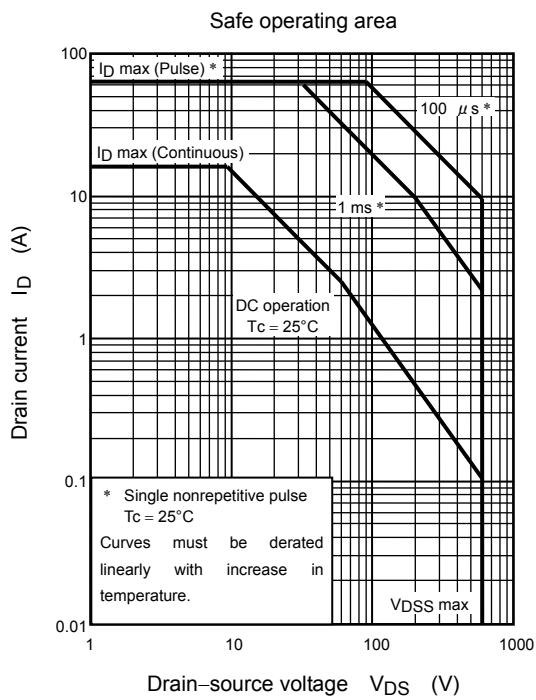
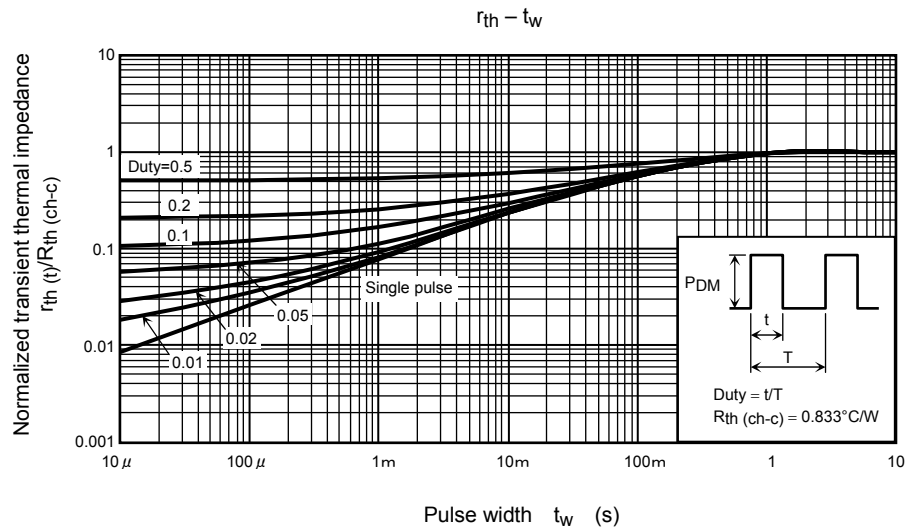
Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current (Note 1)	I_{DR}	—	—	—	16	A
Pulse drain reverse current (Note 1)	I_{DRP}	—	—	—	64	A
Forward voltage (diode)	V_{DSF}	$I_{DR} = 16 \text{ A}, V_{GS} = 0 \text{ V}$	—	—	-1.7	V
Reverse recovery time	t_{rr}	$I_{DR} = 16 \text{ A}, V_{GS} = 0 \text{ V}$	—	1050	—	ns
Reverse recovery charge	Q_{rr}	$dI_{DR} / dt = 100 \text{ A} / \mu\text{s}$	—	15	—	μC

Marking









$$R_G = 25 \, \Omega$$

$$V_{DD} = 90 \, \text{V}, L = 6.69 \, \text{mH}$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I_{AR}^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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